

# AO3418

# 30V N-Channel MOSFET

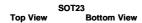
## **General Description**

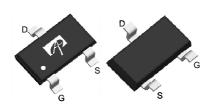
The AO3418 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch or in PWM applications.

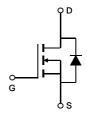
## **Product Summary**

 $\begin{array}{lll} V_{DS} & 30V \\ I_{D} \; (at \, V_{GS} \! = \! 10V) & 3.8A \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 10V) & < 55 m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 4.5V) & < 65 m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 2.5V) & < 85 m\Omega \end{array}$ 









Absolute Maximum Ratings	T <sub>A</sub> =25℃ unless otherwise noted				
Parameter	Symbol				

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V <sub>DS</sub>	30	V	
Gate-Source Voltage		V <sub>GS</sub>	±12	V	
Continuous Drain	T <sub>A</sub> =25℃		3.8		
Current	T <sub>A</sub> =70℃	'D	3.1	A	
Pulsed Drain Current C		I <sub>DM</sub>	15		
	T <sub>A</sub> =25℃	Р	1.4	W	
Power Dissipation <sup>B</sup>	T <sub>A</sub> =70℃	P <sub>D</sub>	0.9	VV	
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	C	

Thermal Characteristics					
Parameter		Symbol	Тур	Max	Units
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta JA}$	70	90	€/W
Maximum Junction-to-Ambient AD	Steady-State		100	125	€/W
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	63	80	€/M



#### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC F	PARAMETERS					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V
1	Zero Gate Voltage Drain Current	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V			1	μΑ
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	T <sub>J</sub> =55℃			5	
$I_{GSS}$	Gate-Body leakage current	$V_{DS}=0V$ , $V_{GS}=\pm 12V$			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$	0.5	1	1.5	V
$I_{D(ON)}$	On state drain current	$V_{GS}$ =10V, $V_{DS}$ =5V	15			Α
		V <sub>GS</sub> =10V, I <sub>D</sub> =3.8A		43	55	mΩ
P	Static Drain-Source On-Resistance	T <sub>J</sub> =125℃		70	84	11152
R <sub>DS(ON)</sub>	Static Dialii-Source Off-Resistance	$V_{GS}$ =4.5V, $I_{D}$ =3.5A		47	65	mΩ
		$V_{GS}$ =2.5V, $I_D$ =1A		59	85	mΩ
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =5V, $I_D$ =3.8A		14		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V		0.75	1	V
Is	Maximum Body-Diode Continuous Curr	rent			1.5	Α
DYNAMIC	PARAMETERS					
C <sub>iss</sub>	Input Capacitance		185	235	285	pF
C <sub>oss</sub>	Output Capacitance	$V_{GS}$ =0V, $V_{DS}$ =15V, f=1MHz	25	35	45	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		10	18	25	pF
$R_g$	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz	2.1	4.3	6.5	Ω
SWITCHI	NG PARAMETERS					
Q <sub>g</sub> (10V)	Total Gate Charge			10	12	nC
Q <sub>g</sub> (4.5V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =3.8A		4.7		nC
$Q_{gs}$	Gate Source Charge	V <sub>GS</sub> -10V, V <sub>DS</sub> -13V, I <sub>D</sub> -3.0A		0.95		nC
$Q_{gd}$	Gate Drain Charge			1.6		nC
t <sub>D(on)</sub>	Turn-On DelayTime			3.5		ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_L$ =3.95 $\Omega$ ,		1.5		ns
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_{GEN}=3\Omega$		17.5		ns
t <sub>f</sub>	Turn-Off Fall Time			2.5		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =3.8A, dI/dt=100A/μs		8.5	11	ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =3.8A, dI/dt=100A/μs		2.6	3.5	nC

A. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25° C. The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $P_D$  is based on the user's specific board design.

C. Repetitive rating, pulse width limited by junction temperature  $P_D$  is based on low frequency and duty cycles to keep

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initial $T_J$ =25 $^{\circ}$  C.

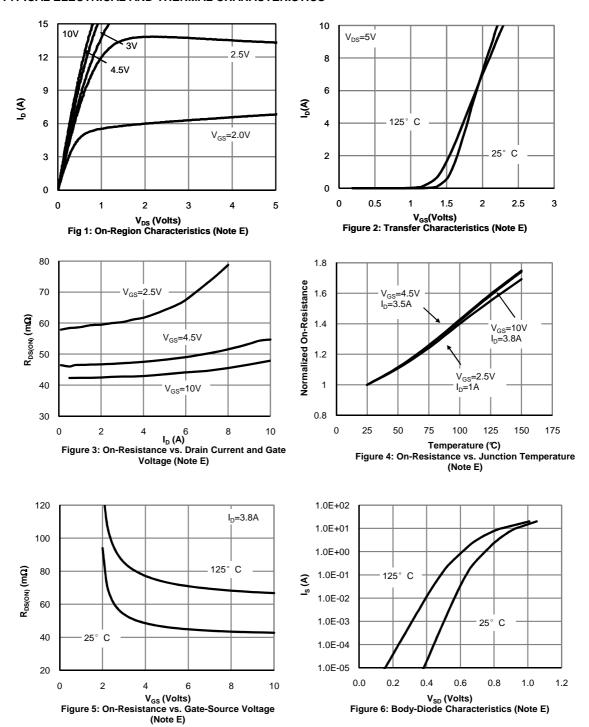
D. The  $R_{\theta JA}$  is the sum of the thermal impedence from junction to lead  $R_{\theta JL}$  and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, assuming a maximum junction temperature of  $T_{J(MAX)}=150^\circ$  C. The SOA curve provides a single pulse rating.



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



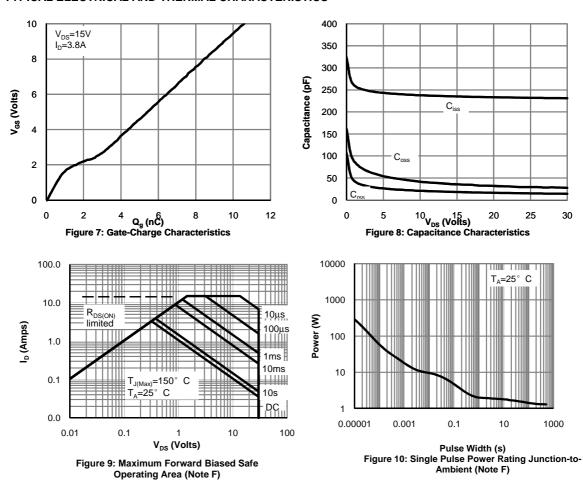


0.0001

0.0001

0.001

#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



10 D=T<sub>on</sub>/T In descending order T<sub>J,PK</sub>=T<sub>A</sub>+P<sub>DM</sub>.Z<sub>θ,JA</sub>.R<sub>θ,JA</sub> D=0.5, 0.3, 0.1, 0.05, 0.02, 0.01, single pulse D=0.5, 0.3 to 1.0 D=0.5 to 2.0 D=0.5 to 3.0 D

Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

0.1

10

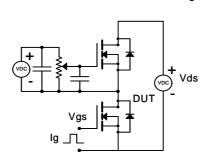
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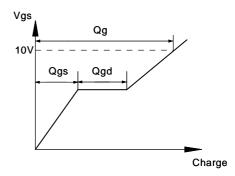
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0.01

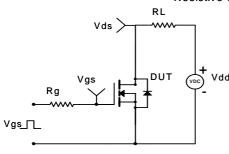


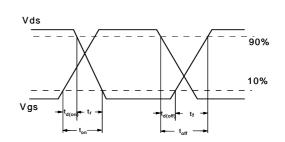
# Gate Charge Test Circuit & Waveform





# Resistive Switching Test Circuit & Waveforms





## Diode Recovery Test Circuit & Waveforms

